

Notice of References Cited	Application/Control No. 10/574,917		Applicant(s)/Patent Under Reexamination FENG ET AL.	
	Examiner Brian-Yong S. Kwon		Art Unit 1614	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,689,808	02-2004	Guo et al.	514/465
*	B	US-7,482,027	01-2009	Kim et al.	424/725
*	C	US-2005/0233004	10-2005	Shin et al.	424/549
*	D	US-2006/0166931	07-2006	Niu et al.	514/058
*	E	US-2006/0246157	11-2006	Kim et al.	424/725
*	F	US-2007/0042057	02-2007	Raederstorff et al.	424/729
*	G	US-2007/0082947	04-2007	D'Orazio et al.	514/469
*	H	US-6,447,814	09-2002	Lee et al.	424/725
*	I	US-2007/0112065	05-2007	Feng et al.	514/469
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63083080 A	04-1988	Japan	OGAWA et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Guo et al., Chin Med J 119(6):662-668, 2006.			
	V	Shimamura et al., Cir 109:424-431, 2004.			
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.